

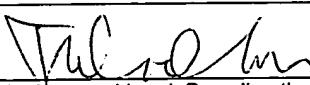
Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 10973-051001	Application No. 09/897,324
<b>Supplemental Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))				Applicant Hiroyuki Makita et al.	O P E R A T I O N S C O M M U N I C A T I O N S U.S. PATENT AND TRADEMARK OFFICE JULY 2002 2877
				Filing Date July 2, 2001	

<b>U.S. Patent Documents</b>							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						

<b>Foreign Patent Documents or Published Foreign Patent Applications</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
AB	DE 298 24 081 U1		13-7-2000	Germany			X
AC	DE 197 56 574 A1		8-10-98	Germany			X
AD	DE 196 32 252 A1		8-1-98	Germany			X
AE	DE 196 34 754 A1		5-3-98	Germany			X
AF							

<b>Other Documents (include Author, Title, Date, and Place of Publication)</b>		
Examiner Initial	Desig. ID	Document
	AG	
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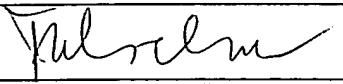
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(37 CFR §1.98(b))				Group Art Unit	

J0973-051001-02/01  
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<b>U.S. Patent Documents</b>							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
TC	AA	5,349,430	09/20/1994	Yamamoto et al.			
TV	AB	5,645,338	07/08/1997	Kobayashi			
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	AI						
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	AK						

<b>Foreign Patent Documents or Published Foreign Patent Applications</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No
	AL						
	AM						
	AN						
	AO						
	AP						

<b>Other Documents (include Author, Title, Date, and Place of Publication)</b>		
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